



# AiP74LV4052

## Dual 4-channel Analog Multiplexer/Demultiplexer

### Product Specification

**Specification Revision History:**

Version	Date	Description
2019-06-A1	2019-06	New
2024-09-B1	2024-09	Update the template; modify the content



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## 1、General Description

The AiP74LV4052 is a dual 4-channel analog multiplexer/demultiplexer with a common select logic. Each multiplexer has four independent inputs/outputs (nY0 to nY3) and a common input/output (nZ). The common channel select logics include two digital select inputs (S0 and S1) and an active LOW enable input ( $\bar{E}$ ). With  $\bar{E}$  LOW, one of the four switches is selected (low impedance ON-state) by S0 and S1.

With  $\bar{E}$  HIGH, all switches are in the high impedance OFF-state, independent of S0 and S1.

$V_{CC}$  and GND are the supply voltage pins for the digital control inputs (S0, S1 and  $\bar{E}$ ). The  $V_{CC}$  to GND ranges are 2.0V to 6.0V. The analog inputs/outputs (nY0, to nY3, and nZ) can swing between  $V_{CC}$  as a positive limit and  $V_{EE}$  as a negative limit.  $V_{CC}-V_{EE}$  may not exceed 6.0V. For operation as a digital multiplexer/demultiplexer,  $V_{EE}$  is connected to GND (typically ground).

### Features:

- Optimized for low-voltage applications: 2.0V to 6.0V
- Accepts TTL input levels between  $V_{CC}=2.7V$  and  $V_{CC}=3.6V$
- Low ON resistance:
  - 110 $\Omega$  (typical) at  $V_{CC}-V_{EE}=2.0V$
  - 90 $\Omega$  (typical) at  $V_{CC}-V_{EE}=3.0V$
  - 60 $\Omega$  (typical) at  $V_{CC}-V_{EE}=4.5V$
- Logic level translation: to enable 3V logic to communicate with  $\pm 3V$  analog signals
- Typical 'break before make' built in
- Specified from -40 $^{\circ}C$  to +125 $^{\circ}C$
- Packaging information: DIP16/SOP16/TSSOP16



## Ordering Information:

### Tube packing specifications:

Part number	Packaging form	Marking code	Tube quantity	Boxed tube quantity	Boxed quantity	Notes
AiP74LV4052DA16.TB	DIP16	74LV4052	25 PCS/tube	40 tube/box	1000 PCS/box	Dimensions of plastic enclosure: 19.0mm×6.4mm Pin spacing: 2.54mm
AiP74LV4052SA16.TB	SOP16	74LV4052	50 PCS/tube	200 tube/box	10000 PCS/box	Dimensions of plastic enclosure: 10.0mm×3.9mm Pin spacing: 1.27mm
AiP74LV4052TA16.TB	TSSOP16	74LV4052	96 PCS/tube	200 tube/box	19200 PCS/box	Dimensions of plastic enclosure: 5.0mm×4.4mm Pin spacing: 0.65mm

### Reel packing specifications:

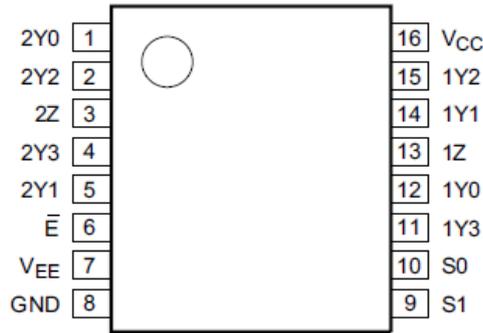
Part number	Packaging form	Marking code	Reel quantity	Boxed reel quantity	Notes
AiP74LV4052SA16.TR	SOP16	74LV4052	4000 PCS/reel	8000 PCS/box	Dimensions of plastic enclosure: 10.0mm×3.9mm Pin spacing:1.27mm
AiP74LV4052TA16.TR	TSSOP16	74LV4052	5000 PCS/reel	10000 PCS/box	Dimensions of plastic enclosure: 5.0mm×4.4mm Pin spacing:0.65mm

Note: If the physical information is inconsistent with the ordering information, please refer to the actual product.





## 2.2、Pin Configurations



## 2.3、Pin Description

Pin No.	Pin Name	Description
1	2Y0	independent input or output
2	2Y2	independent input or output
3	2Z	common output or input
4	2Y3	independent input or output
5	2Y1	independent input or output
6	$\bar{E}$	enable input (active LOW)
7	$V_{EE}$	supply voltage
8	GND	ground (0V)
9	S1	select input
10	S0	select input
11	1Y3	independent input or output
12	1Y0	independent input or output
13	1Z	common output or input
14	1Y1	independent input or output
15	1Y2	independent input or output
16	$V_{CC}$	supply voltage

## 2.4、Function Table

Input			Channel ON
$\bar{E}$	S1	S0	
L	L	L	nY0 to nZ
L	L	H	nY1 to nZ
L	H	L	nY2 to nZ
L	H	H	nY3 to nZ
H	X	X	none

Note: H=HIGH voltage level; L=LOW voltage level; X=don't care.



## 3、Electrical Parameter

### 3.1、Absolute Maximum Ratings

(Voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Max.	Unit
supply voltage	$V_{CC}$	-	-0.5	+7.0	V
input clamping current	$I_{IK}$	$V_I < -0.5V$ or $V_I > V_{CC} + 0.5V$	-	$\pm 20$	mA
switch clamping current	$I_{SK}$	$V_{SW} < -0.5V$ or $V_{SW} > V_{CC} + 0.5V$	-	$\pm 20$	mA
switch current	$I_{SW}$	$V_{SW} > -0.5V$ or $V_{SW} < V_{CC} + 0.5V$ ; source or sink current	-	$\pm 25$	mA
storage temperature	$T_{stg}$	-	-65	+150	°C
total power dissipation	$P_{tot}$	-	-	500	mW
Soldering temperature	$T_L$	10s	DIP		°C
			SOP/TSSOP		
			245		
			260		

### 3.2、Recommended Operating Conditions

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
supply voltage	$V_{CC}$	-	2	3.3	6	V
input voltage	$V_I$	-	0	-	$V_{CC}$	V
switch voltage	$V_{SW}$	-	0	-	$V_{CC}$	V
ambient temperature	$T_{amb}$	in free air	-40	-	+125	°C
input transition rise and fall rate	$\Delta t / \Delta V$	$V_{CC} = 2.0V$ to $2.7V$	-	-	200	ns/V
		$V_{CC} = 2.7V$ to $6.0V$	-	-	100	ns/V



## 3.3、Electrical Characteristics

### 3.3.1、DC Characteristics 1

( $T_{amb}=-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ , voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions (V)	Min.	Typ.	Max.	Unit	
HIGH-level input voltage	$V_{IH}$	$V_{CC}=2.0\text{V}$	1.4	-	-	V	
		$V_{CC}=2.7\text{V}$ to $3.6\text{V}$	2.0	-	-	V	
		$V_{CC}=4.5\text{V}$	3.15	-	-	V	
		$V_{CC}=6.0\text{V}$	4.20	-	-	V	
LOW-level input voltage	$V_{IL}$	$V_{CC}=2.0\text{V}$	-	-	0.6	V	
		$V_{CC}=2.7\text{V}$ to $3.6\text{V}$	-	-	0.8	V	
		$V_{CC}=4.5\text{V}$	-	-	1.35	V	
		$V_{CC}=6.0\text{V}$	-	-	1.80	V	
input leakage current	$I_I$	$V_I=V_{CC}$ or GND	$V_{CC}=3.6\text{V}$	-	-	1.0	$\mu\text{A}$
			$V_{CC}=6.0\text{V}$	-	-	2.0	$\mu\text{A}$
OFF-state leakage current	$I_{S(OFF)}$	$V_I=V_{IH}$ or $V_{IL}$ ; see Figure 13	$V_{CC}=3.6\text{V}$	-	-	1.0	$\mu\text{A}$
			$V_{CC}=6.0\text{V}$	-	-	2.0	$\mu\text{A}$
ON-state leakage current	$I_{S(ON)}$	$V_I=V_{IH}$ or $V_{IL}$ ; see Figure 14	$V_{CC}=3.6\text{V}$	-	-	1.0	$\mu\text{A}$
			$V_{CC}=6.0\text{V}$	-	-	2.0	$\mu\text{A}$
supply current	$I_{CC}$	$V_I=V_{CC}$ or GND; $I_O=0\text{A}$	$V_{CC}=3.6\text{V}$	-	-	20	$\mu\text{A}$
			$V_{CC}=6.0\text{V}$	-	-	40	$\mu\text{A}$
additional supply current	$\Delta I_{CC}$	per input; $V_I=V_{CC}-0.6\text{V}$ ; $V_{CC}=2.7\text{V}$ to $3.6\text{V}$	-	-	500	$\mu\text{A}$	
ON resistance (peak)	$R_{ON(peak)}$	$V_I=0\text{V}$ to $V_{CC}-V_{EE}$	$V_{CC}=2.0\text{V}$ ; $I_{SW}=1000\mu\text{A}$	-	290	650	$\Omega$
			$V_{CC}=2.7\text{V}$ ; $I_{SW}=1000\mu\text{A}$	-	150	300	$\Omega$
			$V_{CC}=3.0\text{V}$ to $3.6\text{V}$ ; $I_{SW}=1000\mu\text{A}$	-	100	200	$\Omega$
			$V_{CC}=4.5\text{V}$ ; $I_{SW}=1000\mu\text{A}$	-	80	160	$\Omega$
			$V_{CC}=6.0\text{V}$ ; $I_{SW}=1000\mu\text{A}$	-	65	130	$\Omega$
ON resistance mismatch between channels	$\Delta R_{ON}$	$V_I=0\text{V}$ to $V_{CC}-V_{EE}$	$V_{CC}=2.0\text{V}$ ; $I_{SW}=1000\mu\text{A}$	-	5	-	$\Omega$
			$V_{CC}=2.7\text{V}$ ; $I_{SW}=1000\mu\text{A}$	-	4	-	$\Omega$
			$V_{CC}=3.0\text{V}$ to $3.6\text{V}$ ; $I_{SW}=1000\mu\text{A}$	-	4	-	$\Omega$
			$V_{CC}=4.5\text{V}$ ; $I_{SW}=1000\mu\text{A}$	-	3	-	$\Omega$
			$V_{CC}=6.0\text{V}$ ; $I_{SW}=1000\mu\text{A}$	-	2	-	$\Omega$
ON resistance (rail)	$R_{ON(rail)}$	$V_I=\text{GND}$	$V_{CC}=2.0\text{V}$ ; $I_{SW}=1000\mu\text{A}$	-	110	235	$\Omega$



		$V_I = V_{CC} - V_{EE}$	$V_{CC}=2.7V;$ $I_{SW}=1000\mu A$	-	85	170	$\Omega$
			$V_{CC}=3.0V$ to $3.6V;$ $I_{SW}=1000\mu A$	-	65	130	$\Omega$
			$V_{CC}=4.5V;$ $I_{SW}=1000\mu A$	-	60	120	$\Omega$
			$V_{CC}=6.0V;$ $I_{SW}=1000\mu A$	-	50	100	$\Omega$
			$V_{CC}=2.0V;$ $I_{SW}=1000\mu A$	-	150	320	$\Omega$
			$V_{CC}=2.7V;$ $I_{SW}=1000\mu A$	-	110	220	$\Omega$
			$V_{CC}=3.0V$ to $3.6V;$ $I_{SW}=1000\mu A$	-	85	170	$\Omega$
			$V_{CC}=4.5V;$ $I_{SW}=1000\mu A$	-	70	140	$\Omega$
			$V_{CC}=6.0V;$ $I_{SW}=1000\mu A$	-	60	120	$\Omega$

Note:

[1] Typical values are measured at  $T_{amb}=25^{\circ}C$ .

### 3.3.2、DC Characteristics 2

( $T_{amb}=-40^{\circ}C$  to  $+125^{\circ}C$ , voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions (V)	Min.	Typ.	Max.	Unit	
HIGH-level input voltage	$V_{IH}$	$V_{CC}=2.0V$	1.4	-	-	V	
		$V_{CC}=2.7V$ to $3.6V$	2.0	-	-	V	
		$V_{CC}=4.5V$	3.15	-	-	V	
		$V_{CC}=6.0V$	4.20	-	-	V	
LOW-level input voltage	$V_{IL}$	$V_{CC}=2.0V$	-	-	0.6	V	
		$V_{CC}=2.7V$ to $3.6V$	-	-	0.8	V	
		$V_{CC}=4.5V$	-	-	1.35	V	
		$V_{CC}=6.0V$	-	-	1.80	V	
input leakage current	$I_I$	$V_I = V_{CC}$ or GND	$V_{CC}=3.6V$	-	-	2.0	$\mu A$
			$V_{CC}=6.0V$	-	-	4.0	$\mu A$
OFF-state leakage current	$I_{S(OFF)}$	$V_I = V_{IH}$ or $V_{IL};$ see Figure 13	$V_{CC}=3.6V$	-	-	2.0	$\mu A$
			$V_{CC}=6.0V$	-	-	4.0	$\mu A$
ON-state leakage current	$I_{S(ON)}$	$V_I = V_{IH}$ or $V_{IL};$ see Figure 14	$V_{CC}=3.6V$	-	-	2.0	$\mu A$
			$V_{CC}=6.0V$	-	-	4.0	$\mu A$
supply current	$I_{CC}$	$V_I = V_{CC}$ or GND; $I_O=0A$	$V_{CC}=3.6V$	-	-	40	$\mu A$
			$V_{CC}=6.0V$	-	-	80	$\mu A$
additional supply current	$\Delta I_{CC}$	per input; $V_I = V_{CC} - 0.6V;$ $V_{CC}=2.7V$ to $3.6V$	-	-	850	$\mu A$	
ON resistance (peak)	$R_{ON(peak)}$	$V_I = 0V$ to $V_{CC} - V_{EE}$	$V_{CC}=2.0V;$ $I_{SW}=1000\mu A$	-	-	750	$\Omega$



			$V_{CC}=2.7V;$ $I_{SW}=1000\mu A$	-	-	350	$\Omega$
			$V_{CC}=3.0V$ to $3.6V;$ $I_{SW}=1000\mu A$	-	-	250	$\Omega$
			$V_{CC}=4.5V;$ $I_{SW}=1000\mu A$	-	-	200	$\Omega$
			$V_{CC}=6.0V;$ $I_{SW}=1000\mu A$	-	-	150	$\Omega$
ON resistance (rail)	$R_{ON(rail)}$	$V_I=GND$	$V_{CC}=2.0V;$ $I_{SW}=1000\mu A$	-	-	750	$\Omega$
			$V_{CC}=2.7V;$ $I_{SW}=1000\mu A$	-	-	270	$\Omega$
			$V_{CC}=3.0V$ to $3.6V;$ $I_{SW}=1000\mu A$	-	-	200	$\Omega$
			$V_{CC}=4.5V;$ $I_{SW}=1000\mu A$	-	-	150	$\Omega$
			$V_{CC}=6.0V;$ $I_{SW}=1000\mu A$	-	-	140	$\Omega$
		$V_I=V_{CC}-V_{EE}$	$V_{CC}=2.0V;$ $I_{SW}=1000\mu A$	-	-	120	$\Omega$
			$V_{CC}=2.7V;$ $I_{SW}=1000\mu A$	-	-	370	$\Omega$
			$V_{CC}=3.0V$ to $3.6V;$ $I_{SW}=1000\mu A$	-	-	250	$\Omega$
			$V_{CC}=4.5V;$ $I_{SW}=1000\mu A$	-	-	205	$\Omega$
			$V_{CC}=6.0V;$ $I_{SW}=1000\mu A$	-	-	150	$\Omega$



### 3.3.3、AC Characteristics 1

( $T_{amb}=-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ , voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit	
propagation delay	$t_{pd}$	nYn to nZ, nZ to nYn; see Figure 4	$V_{CC}=2.0\text{V}$	-	9	17	ns
			$V_{CC}=2.7\text{V}$	-	6	13	ns
			$V_{CC}=3.0\text{V}$ to $3.6\text{V}$	-	5	10	ns
			$V_{CC}=4.5\text{V}$	-	4	9	ns
			$V_{CC}=6.0\text{V}$	-	3	7	ns
enable time	$t_{en}$	$\bar{E}, \text{Sn}$ to nYn, nZ; see Figure 5	$V_{CC}=2.0\text{V}$	-	65	121	ns
			$V_{CC}=2.7\text{V}$	-	48	89	ns
			$V_{CC}=3.0\text{V}$ to $3.6\text{V}$ ; $C_L=15\text{pF}$	-	30	-	ns
			$V_{CC}=3.0\text{V}$ to $3.6\text{V}$	-	36	71	ns
			$V_{CC}=4.5\text{V}$	-	32	60	ns
			$V_{CC}=6.0\text{V}$	-	25	46	ns
disable time	$t_{dis}$	$\bar{E}, \text{Sn}$ to nYn, nZ; see Figure 5	$V_{CC}=2.0\text{V}$	-	43	80	ns
			$V_{CC}=2.7\text{V}$	-	33	59	ns
			$V_{CC}=3.0\text{V}$ to $3.6\text{V}$ ; $C_L=15\text{pF}$	-	22	-	ns
			$V_{CC}=3.0\text{V}$ to $3.6\text{V}$	-	26	48	ns
			$V_{CC}=4.5\text{V}$	-	23	41	ns
			$V_{CC}=6.0\text{V}$	-	28	32	ns

Note:

[1] Typical values are measured at  $T_{amb}=25^{\circ}\text{C}$ .

[2]  $t_{pd}$  is the same as  $t_{PLH}$  and  $t_{PHL}$ .

$t_{en}$  is the same as  $t_{PZL}$  and  $t_{PZH}$ .

$t_{dis}$  is the same as  $t_{PLZ}$  and  $t_{PHZ}$ .



### 3.3.4、AC Characteristics 2

( $T_{amb}=-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ , voltages are referenced to GND (ground=0V), unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit	
propagation delay	$t_{pd}$	nYn to nZ, nZ to nYn; see Figure 4	$V_{CC}=2.0\text{V}$	-	-	20	ns
			$V_{CC}=2.7\text{V}$	-	-	15	ns
			$V_{CC}=3.0\text{V}$ to $3.6\text{V}$	-	-	12	ns
			$V_{CC}=4.5\text{V}$	-	-	10	ns
			$V_{CC}=6.0\text{V}$	-	-	8	ns
enable time	$t_{en}$	$\bar{E}$ , Sn to nYn, nZ; see Figure 5	$V_{CC}=2.0\text{V}$	-	-	146	ns
			$V_{CC}=2.7\text{V}$	-	-	108	ns
			$V_{CC}=3.0\text{V}$ to $3.6\text{V}$	-	-	86	ns
			$V_{CC}=4.5\text{V}$	-	-	73	ns
			$V_{CC}=6.0\text{V}$	-	-	56	ns
disable time	$t_{dis}$	$\bar{E}$ , Sn to nYn, nZ; see Figure 5	$V_{CC}=2.0\text{V}$	-	-	95	ns
			$V_{CC}=2.7\text{V}$	-	-	71	ns
			$V_{CC}=3.0\text{V}$ to $3.6\text{V}$	-	-	57	ns
			$V_{CC}=4.5\text{V}$	-	-	49	ns
			$V_{CC}=6.0\text{V}$	-	-	38	ns

Note:

[1]  $t_{pd}$  is the same as  $t_{PLH}$  and  $t_{PHL}$ .

$t_{en}$  is the same as  $t_{PZL}$  and  $t_{PZH}$ .

$t_{dis}$  is the same as  $t_{PLZ}$  and  $t_{PHZ}$ .

### 3.3.5、AC Characteristics 3

( $T_{amb}=25^{\circ}\text{C}$ , GND=0V,  $t_r=t_f \leq 6.0\text{ns}$ ,  $V_I=\text{GND}$  or  $V_{CC}$ , unless otherwise specified.)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit	
total harmonic distortion	THD	$f_i=1\text{kHz}$ ; $C_L=50\text{pF}$ ; $R_L=10\text{k}\Omega$ ; see Figure 8	$V_{CC}=3.0\text{V}$ ; $V_I=2.75\text{V(p-p)}$	-	0.8	-	%
			$V_{CC}=6.0\text{V}$ ; $V_I=5.5\text{V(p-p)}$	-	0.4	-	%
		$f_i=10\text{kHz}$ ; $C_L=50\text{pF}$ ; $R_L=10\text{k}\Omega$ ; see Figure 8	$V_{CC}=3.0\text{V}$ ; $V_I=2.75\text{V(p-p)}$	-	2.4	-	%
			$V_{CC}=6.0\text{V}$ ; $V_I=5.5\text{V(p-p)}$	-	1.2	-	%
-3dB frequency response	$f_{(-3\text{dB})}$	$C_L=50\text{pF}$ ; $R_L=50\Omega$ ; see Figure 6	$V_{CC}=3.0\text{V}$	-	180	-	MHz
			$V_{CC}=6.0\text{V}$	-	200	-	MHz
isolation (OFF-state)	$\alpha_{iso}$	$f_i=1\text{MHz}$ ; $C_L=50\text{pF}$ ; $R_L=600\Omega$ ; see Figure 7	$V_{CC}=3.0\text{V}$	-	-50	-	dB
			$V_{CC}=6.0\text{V}$	-	-50	-	dB
crosstalk voltage	$V_{ct}$	between digital inputs and switch; $f_i=1\text{MHz}$ ; $C_L=50\text{pF}$ ; $R_L=600\Omega$ ; see Figure 9	$V_{CC}=3.0\text{V}$	-	0.11	-	V
			$V_{CC}=6.0\text{V}$	-	0.12	-	V
crosstalk	Xtalk	between switches; $f_i=1\text{MHz}$ ; $C_L=50\text{pF}$ ; $R_L=600\Omega$ ; see Figure 10	$V_{CC}=3.0\text{V}$	-	-60	-	dB
			$V_{CC}=6.0\text{V}$	-	-60	-	dB



Note:

- [1] To obtain 0dBm level at output for 1MHz (0dBm=1mW into 50Ω), adjust  $f_i$  voltage.
- [2] To obtain 0dBm level at output for 1MHz (0dBm=1mW into 600Ω), adjust  $f_i$  voltage.

## 4、Testing Circuit

### 4.1、AC Testing Circuit 1

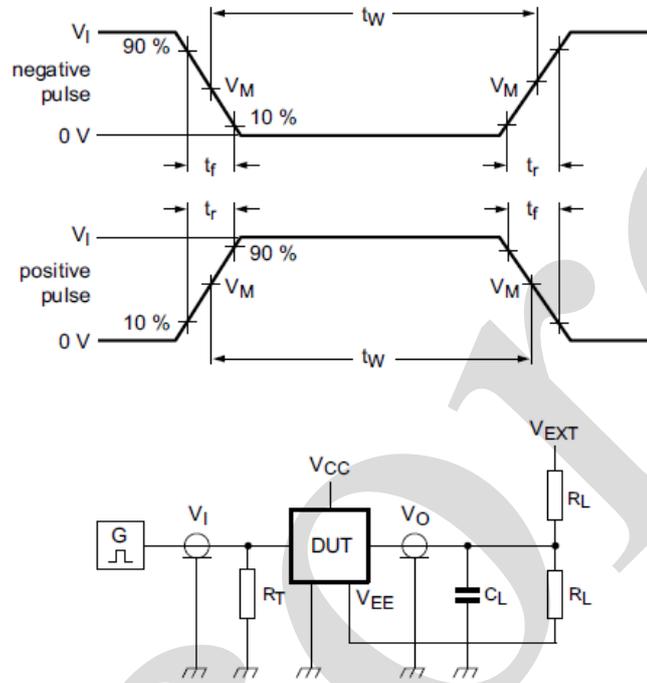


Figure 3. Test circuit for switching times

Definitions for test circuit:

$C_L$ =Load capacitance including jig and probe capacitance.

$R_T$ =Termination resistance should be equal to the output impedance  $Z_o$  of the pulse generator.

$R_L$ =Load resistance.

$V_{EXT}$ =External voltage for measuring switching times.

### 4.2、AC Testing Waveforms

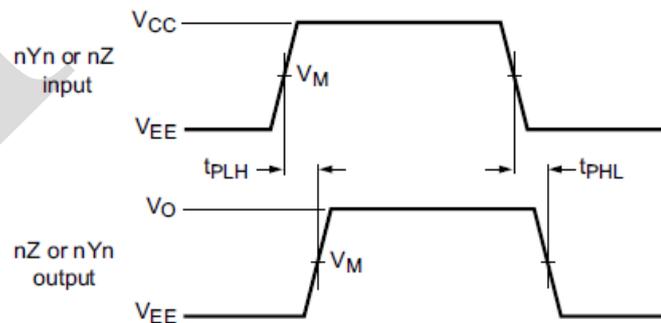
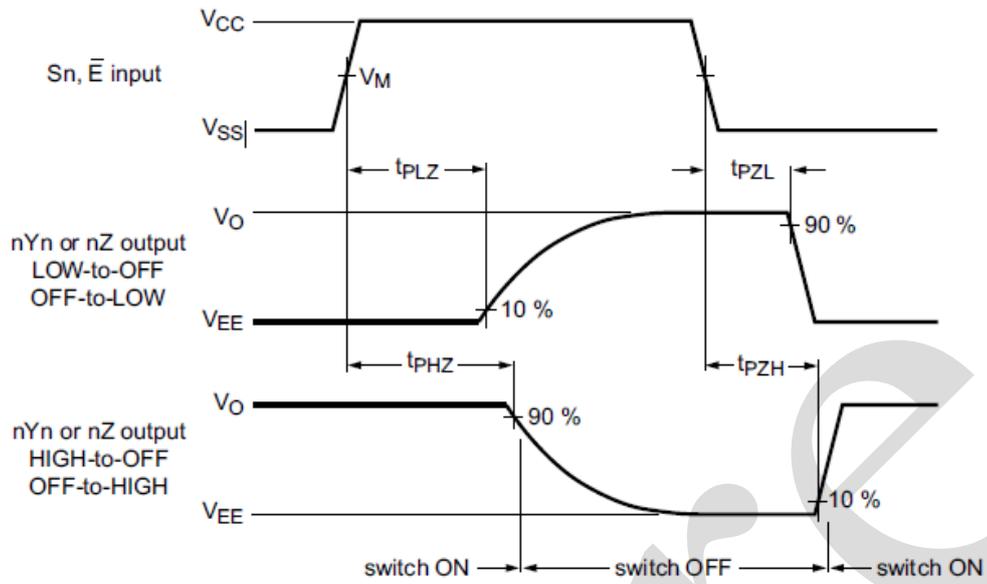
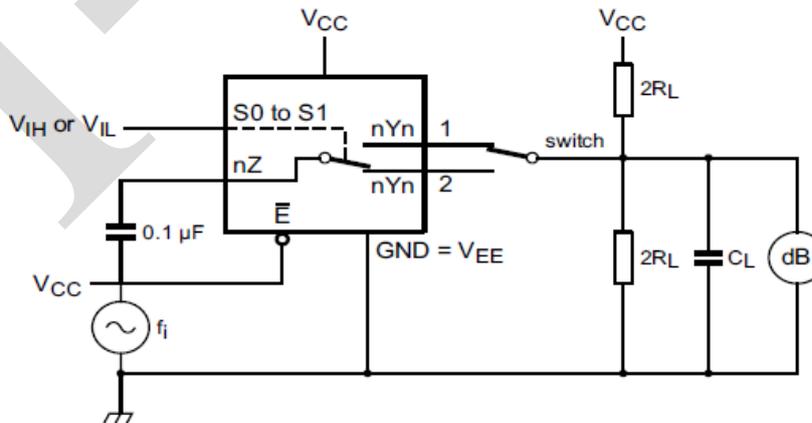
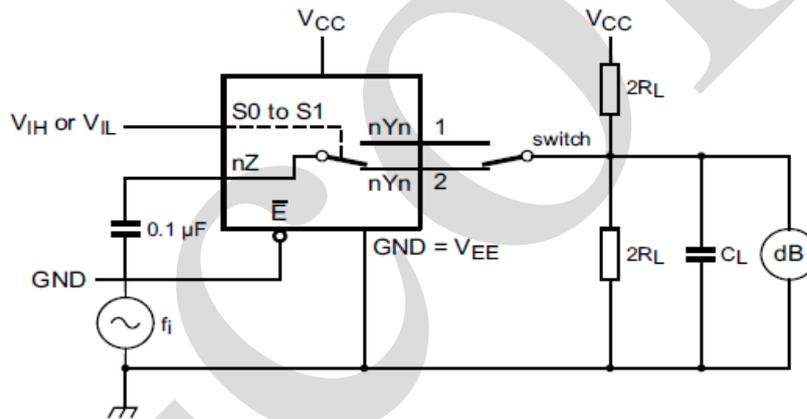


Figure 4. nYn, nZ to nZ, nYn propagation delays



### 4.3. AC Testing Circuit 2



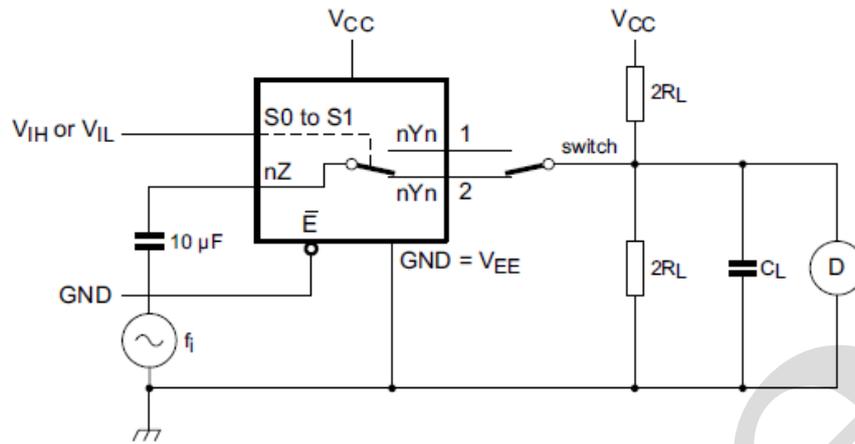
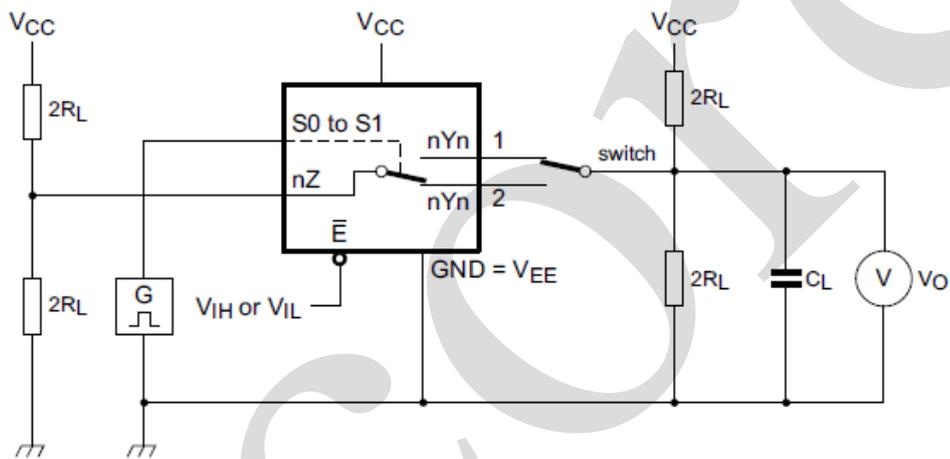
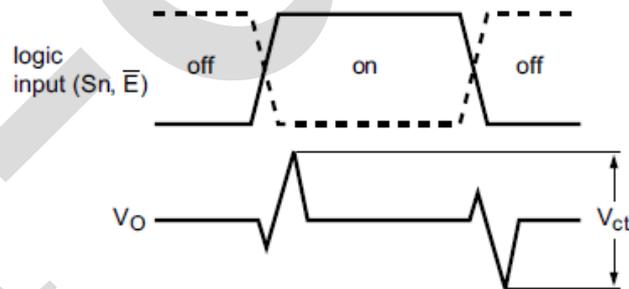


Figure 8. Test circuit for measuring total harmonic distortion



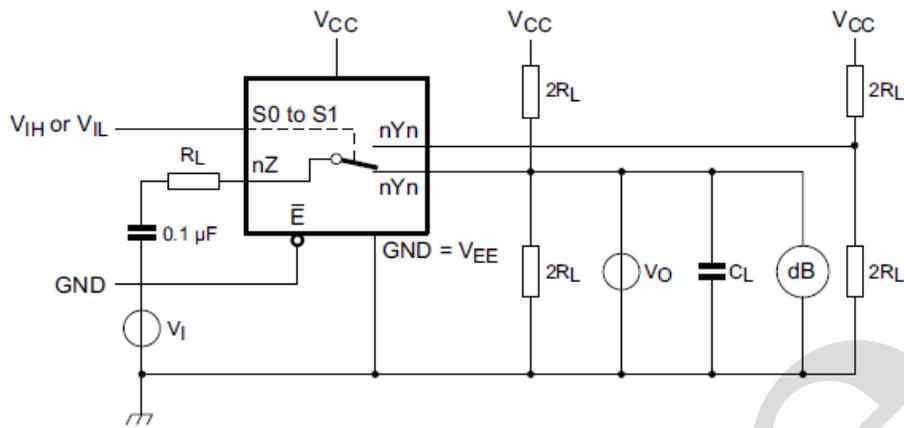
a. Test circuit



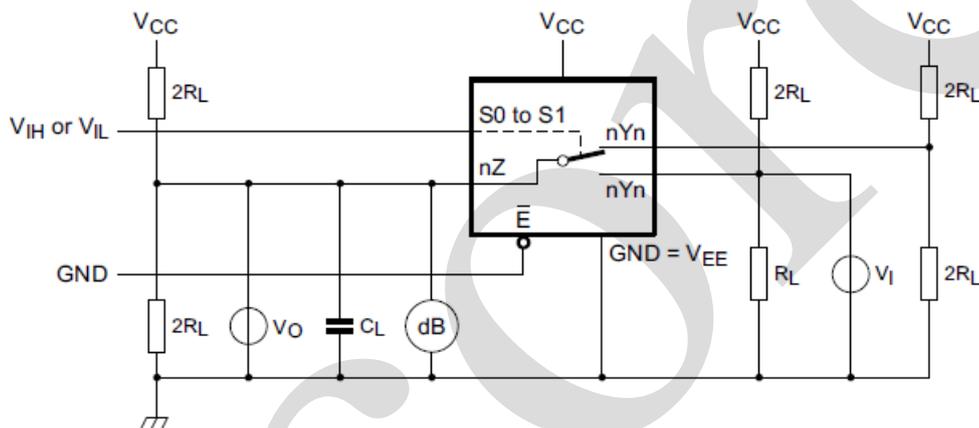
b. Input and output pulse definitions

$V_I$  may be connected to  $S_n$  or  $\bar{E}$ .

Figure 9. Test circuit for measuring crosstalk voltage between digital inputs and switch



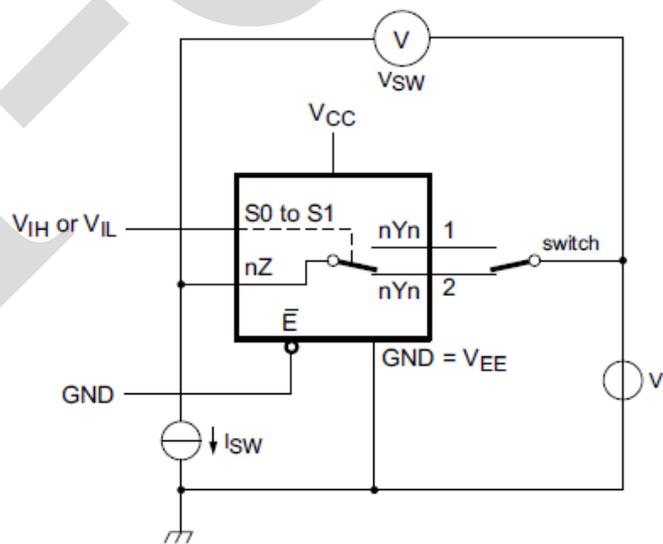
a. Switch on channel.



b. Switch off channel

Figure 10. Test circuit for measuring crosstalk between switches

#### 4.4. On Resistance Waveform And Test Circuit



$$R_{ON} = V_{SW} / I_{SW}$$

Figure 11. Test circuit for measuring  $R_{ON}$

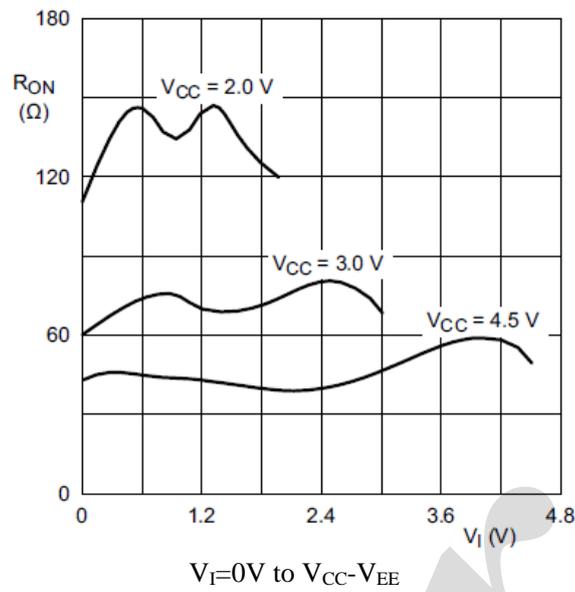
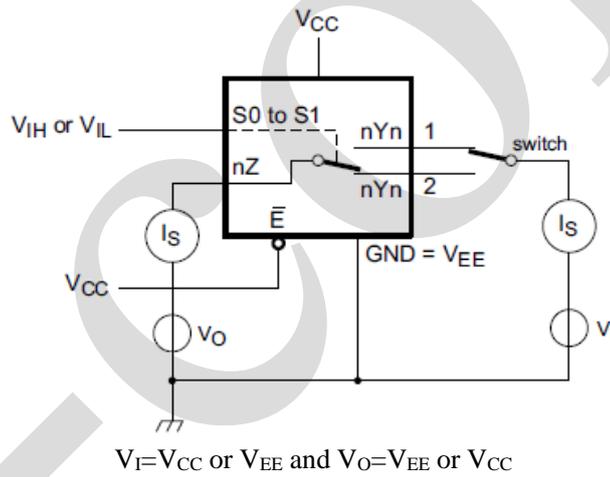


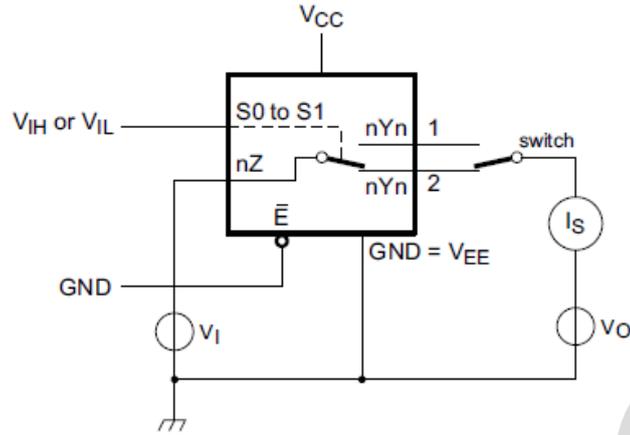
Figure 12. Typical  $R_{ON}$  as a function of input voltage

#### 4.5. DC Testing Circuit



$V_I = V_{CC} \text{ or } V_{EE} \text{ and } V_O = V_{EE} \text{ or } V_{CC}$

Figure 13. Test circuit for measuring OFF-state leakage current



$V_I = V_{CC}$  or  $V_{EE}$  and  $V_O = \text{open circuit}$

Figure 14. Test circuit for measuring ON-state leakage current

#### 4.6. Measurement Points

Supply voltage	Input	Output
$V_{CC}$	$V_M$	$V_M$
$<2.7V$	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$
$2.7V$ to $3.6V$	$1.5V$	$1.5V$
$>3.6V$	$0.5 \times V_{CC}$	$0.5 \times V_{CC}$

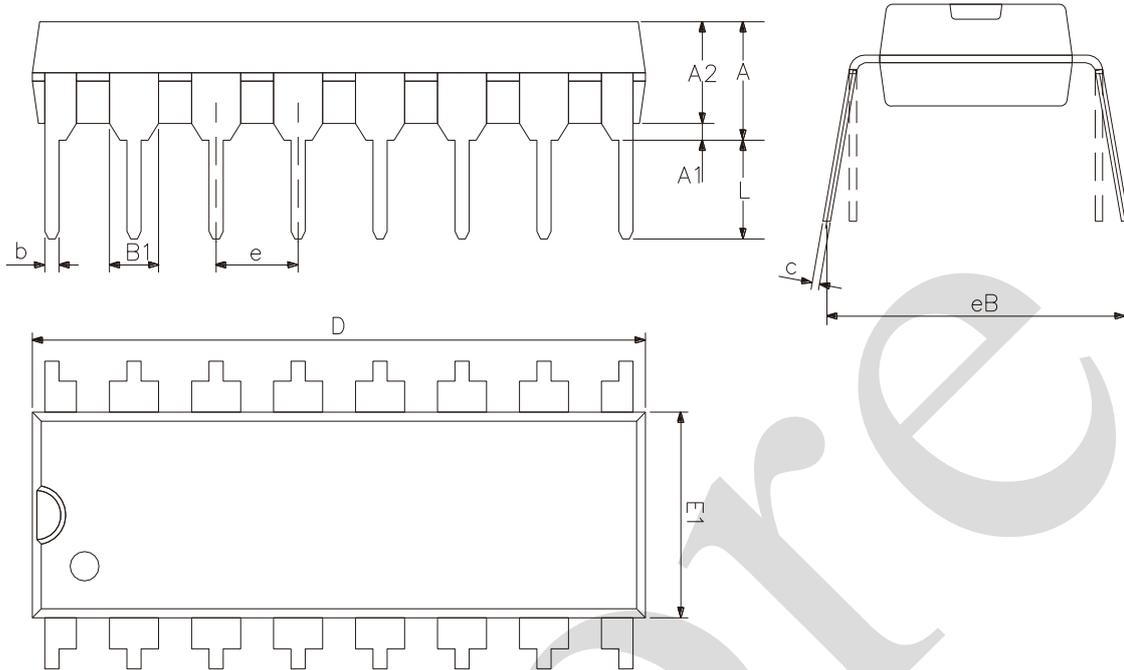
#### 4.7. Test Data

Supply voltage	Input		Load		$V_{EXT}$		
	$V_I$	$t_r, t_f$	$C_L$	$R_L$	$t_{PHL}, t_{PLH}$	$t_{PZH}, t_{PHZ}$	$t_{PZL}, t_{PLZ}$
$<2.7V$	$V_{CC}$	$\leq 6ns$	$50pF$	$1k\Omega$	open	$V_{EE}$	$2 \times V_{CC}$
$2.7V$ to $3.6V$	$2.7V$	$\leq 6ns$	$15 pF, 50pF$	$1k\Omega$	open	$V_{EE}$	$2 \times V_{CC}$
$>3.6V$	$V_{CC}$	$\leq 6ns$	$50pF$	$1k\Omega$	open	$V_{EE}$	$2 \times V_{CC}$



## 5、Package Information

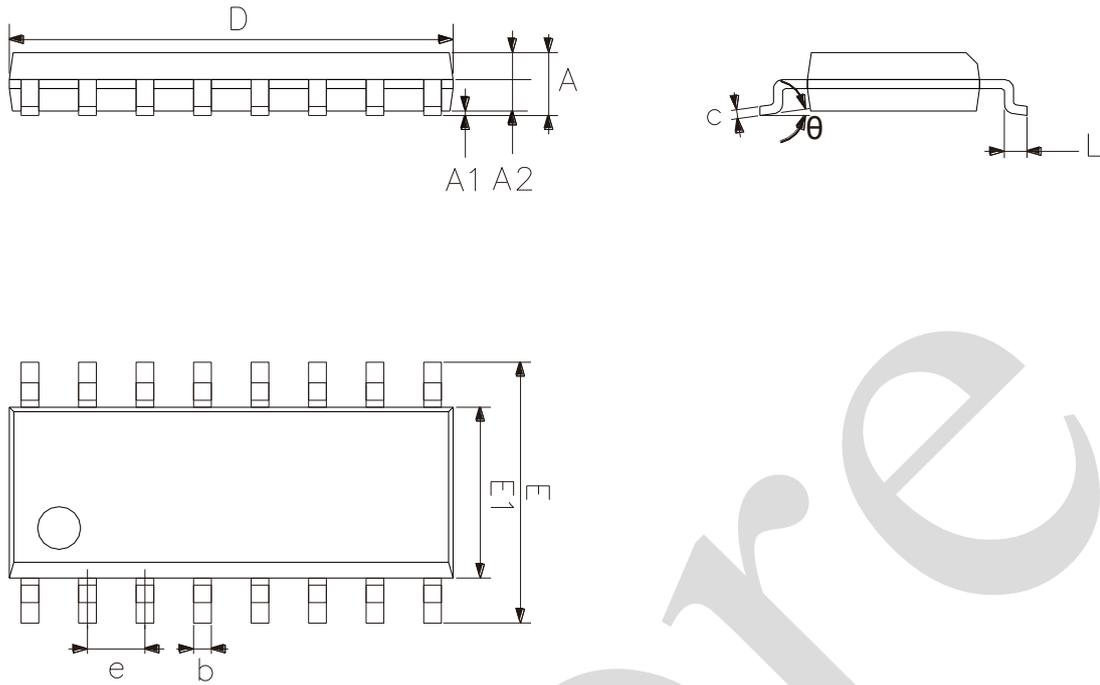
### 5.1、DIP16



2023/12/A Symbol	Dimensions In Millimeters	
	Min	Max
A2	3.00	3.60
A1	0.51	—
A	3.60	5.33
L	3.00	3.60
b	0.36	0.56
B1	1.52	
D	18.80	19.94
E1	6.20	6.60
e	2.54	
c	0.20	0.36
eB	7.62	9.30



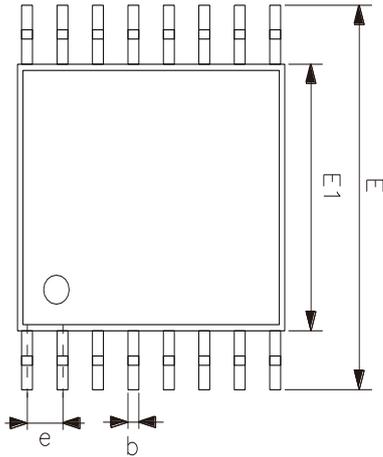
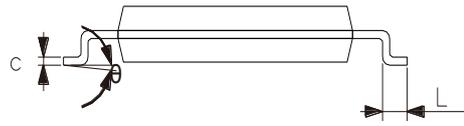
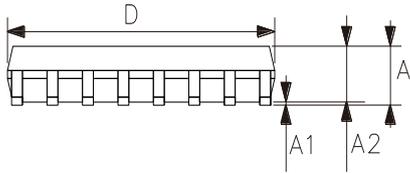
5.2、SOP16



2023/12/A	Dimensions In Millimeters	
	Min.	Max.
A	1.35	1.80
A1	0.10	0.25
A2	1.25	1.55
b	0.33	0.51
c	0.19	0.25
D	9.50	10.10
E	5.80	6.30
E1	3.70	4.10
e	1.27	
L	0.35	0.89
$\theta$	0°	8°



5.3、TSSOP16



2023/12/A	Dimensions In Millimeters	
Symbol	Min	Max
A	—	1.20
A1	0.05	0.15
A2	0.80	1.05
b	0.19	0.30
c	0.09	0.20
D	4.90	5.10
E1	4.30	4.50
E	6.20	6.60
e	0.65	
L	0.45	0.75
$\theta$	0°	8°



## 6、 Statements And Notes

### 6.1、 The name and content of Hazardous substances or Elements in the product

Part name	Hazardous substances or Elements									
	Lead and lead compounds	Mercury and mercury compounds	Cadmium and cadmium compounds	Hexavalent chromium compounds	Polybrominated biphenyls	Polybrominated biphenyl ethers	Dibutyl phthalate	Butylbenzyl phthalate	Di-2-ethylhexyl phthalate	Diisobutyl phthalate
Lead frame	○	○	○	○	○	○	○	○	○	○
Plastic resin	○	○	○	○	○	○	○	○	○	○
Chip	○	○	○	○	○	○	○	○	○	○
The lead	○	○	○	○	○	○	○	○	○	○
Plastic sheet installed	○	○	○	○	○	○	○	○	○	○
explanation	○: Indicates that the content of hazardous substances or elements in the detection limit of the following the SJ/T11363-2006 standard. ×: Indicates that the content of hazardous substances or elements exceeding the SJ/T11363-2006 Standard limit requirements.									

### 6.2、 Notes

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